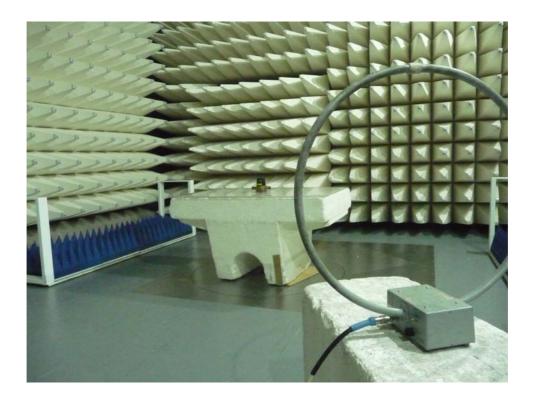


Photograph No.1 Setup for spurious emission measurements in the anechoic chamber below 30 MHz



Photograph No.2 Setup for OBW, carrier field strength and spurious emission measurements in the anechoic chamber below 1000 MHz



Photograph No.3 Setup for OBW, peak output power and spurious emission measurements in the anechoic chamber below 1000 MHz, EUT close view



Photograph No.4 Setup for spurious emission measurements in the anechoic chamber above 1000 MHz

